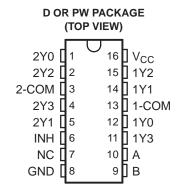
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#### **FEATURES**

- Qualified for Automotive Applications
- Injection-Current Cross Coupling <1 mV/mA (see Figure 1)
- Low Crosstalk Between Switches
- Pin Compatible With SN74HC4052, SN74LV4052A, and CD4052B
- 2-V to 6-V V<sub>CC</sub> Operation



NC - No internal connection

#### **DESCRIPTION/ORDERING INFORMATION**

This dual 4-to-1 CMOS analog multiplexer/demultiplexer is pin compatible with the 4052 function and also features injection-current effect control. This feature has excellent value in automotive applications where voltages in excess of normal supply voltages are common.

The injection-current effect control allows signals at disabled analog input channels to exceed the supply voltage without affecting the signal of the enabled analog channel. This eliminates the need for external diode/resistor networks typically used to keep the analog channel signals within the supply voltage range.

#### ORDERING INFORMATION(1)

T <sub>A</sub>	PACK	AGE <sup>(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 125°C	SOIC - D	Reel of 2500	SN74HC4852QDRQ1	HC4852Q
-40 C 10 125°C	TSSOP - PW	Reel of 2000	SN74HC4852QPWRQ1	HC4852Q

<sup>(1)</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

#### **FUNCTION TABLE**

	INPUTS		ON
INH	В	Α	CHANNEL
L	L	L	1Y0, 2Y0
L	L	Н	1Y1, 2Y1
L	Н	L	1Y2, 2Y2
L	Н	Н	1Y3, 2Y3
Н	Χ	Χ	None



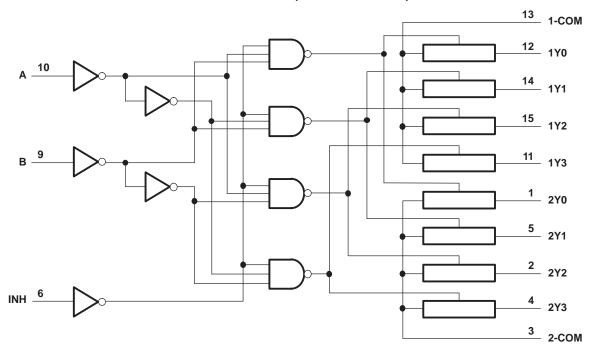
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

<sup>(2)</sup> Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

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## **LOGIC DIAGRAM (POSITIVE LOGIC)**





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## Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
VI	Input voltage range (2)		-0.5	V <sub>CC</sub> + 0.5	V
V <sub>IO</sub>	Switch I/O voltage range <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	$V_I < 0$ or $V_I > V_{CC}$		±20	mA
I <sub>IOK</sub>	I/O diode current	$V_I < 0 \text{ or } V_I > V_{CC}$ $V_{IO} < 0 \text{ or } V_{IO} > V_{CC}$		±20	mA
Is	Switch through current	$V_{IO} = 0$ to $V_{CC}$		±25	mA
	Continuous current through V <sub>CC</sub> or GND			±50	mA
0	Package thermal impedance (4)	D package		73	°C/W
$\theta_{JA}$	Package thermal impedance 17	PW package		108	°C/VV
T <sub>stg</sub>	Storage temperature range		-65	150	°C
		Human-Body Model (HBM)		2000	
ESD	Electrostatic discharge protection	Machine Model (MM)		200	V
		Charged-Device Model (CDM)		1000	

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## Recommended Operating Conditions<sup>(1)</sup>

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		2	6	V	
		V <sub>CC</sub> = 2 V	1.5			
		V <sub>CC</sub> = 3 V	2.1			
$V_{IH}$	High-level input voltage, control inputs	V <sub>CC</sub> = 3.3 V	2.3		V	
		V <sub>CC</sub> = 4.5 V	3.15			
		V <sub>CC</sub> = 6 V	4.2			
		V <sub>CC</sub> = 2 V		0.5		
$V_{IL}$		V <sub>CC</sub> = 3 V		0.9		
	Low-level input voltage, control inputs	V <sub>CC</sub> = 3.3 V		1	V	
		V <sub>CC</sub> = 4.5 V		1.35		
		V <sub>CC</sub> = 6 V		1.8		
VI	Control input voltage		0	V <sub>CC</sub>	V	
V <sub>IO</sub>	Input/output voltage		0	$V_{CC}$	V	
		V <sub>CC</sub> = 2 V		1000		
		V <sub>CC</sub> = 3 V		800		
$\Delta t/\Delta v$	Input transition rise or fall rate	V <sub>CC</sub> = 3.3 V		700	ns	
		V <sub>CC</sub> = 4.5 V		500		
		V <sub>CC</sub> = 6 V		400		
T <sub>A</sub>	Operating free-air temperature		-40	125	°C	

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> This value is limited to 5.5 V maximum.

<sup>(4)</sup> The package thermal impendance is calculated in accordance with JESD 51-7.

TEXAS INSTRUMENTS www.ti.com

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#### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

	DADAMETED	TEST	V	T <sub>A</sub>	= 25°C		–40°C to 85°C	-40°C to 125°C	С	LINUT
	PARAMETER	CONDITIONS	V <sub>CC</sub>	MIN	TYP	MAX	MIN MAX	MIN MA	ΔX	UNIT
			2 V		500	650	670	7	00	
		$I_S \le 2 \text{ mA},$	3 V		215	280	320	3	60	
r <sub>on</sub>	On-state switch resistance	$V_I = V_{CC}$ to GND, $V_{INH} = V_{II}$	3.3 V		210	270	305	3	45	Ω
	resistance	(see Figure 5)	4.5 V		160	210	240	2	70	
			6 V		150	195	220	2	50	
			2 V		4	20	24		26	
	Difference in	I <sub>S</sub> ≤ 2 mA,	3 V		2	14	16	6	18	
$\Delta r_{on}$	on-state resistance	$V_I = V_{CC}/2$ ,	3.3 V		2	14	16	3	18	Ω
	between switches	$V_{INH} = V_{IL}$	4.5 V		2	10	14		18	
			6 V		3	11	15	i	20	
I	Control input current	$V_I = V_{CC}$ or GND	6 V			±0.1	±0.1		±1	μΑ
	Off-state switch leakage current (any one channel)	$V_I = V_{CC}$ or GND, $V_{INH} = V_{IH}$ (see Figure 6)				±0.1	±0.5	í	±1	
I <sub>S(off)</sub>	Off-state switch leakage current (common channel)	$V_{I} = V_{CC}$ or GND, $V_{INH} = V_{IH}$ (see Figure 7)	6 V			±0.2	±2	:	±4	μА
I <sub>S(on)</sub>	On-state switch leakage current	$V_{I} = V_{CC}$ or GND, $V_{INH} = V_{IL}$ (see Figure 8)	6 V			±0.1	±0.5		±1	μΑ
$I_{CC}$	Supply current	$V_I = V_{CC}$ or GND	6 V			2	Ę	<b>;</b>	10	μΑ
C <sub>IC</sub>	Control input capacitance	A, B, INH			3.5	10	10		10	pF
C <sub>IS</sub>	Common terminal capacitance	Switch off			22	40	40		40	pF
Cos	Switch terminal capacitance	Switch off			6.7	15	15	;	15	pF

### **Injection-Current Coupling Specifications**

 $T_A = -40^{\circ}C$  to 125°C (see Figure 1)

	PARAMETER	V <sub>CC</sub>	TEST CO	NDITIONS	MIN TYP <sup>(1)</sup>	MAX	UNIT
		3.3 V	I <sub>I</sub> <sup>(2)</sup> ≤ 1 mA		0.05	1	
		5 V	ll, \ ≥ 1 mA	- R <sub>S</sub> ≤ 3.9 kΩ	0.1	1	
	Maximum shift of output voltage of	3.3 V	I <sub>I</sub> <sup>(2)</sup> ≤ 10 mA		0.345	5	
V		5 V			0.067	5	mV
$V_{\Delta out}$	enabled analog channel	3.3 V	I <sub>I</sub> <sup>(2)</sup> ≤ 1 mA	R <sub>S</sub> ≤ 20 kΩ	0.05	2	IIIV
		5 V			0.11	2	
ı		3.3 V	I <sub>I</sub> <sup>(2)</sup> ≤ 10 mA		0.05	20	
		5 V			0.024	20	

<sup>(1)</sup> Typical values are measured at  $T_A = 25$ °C.

<sup>(2)</sup> I<sub>I</sub> = total current injected into all disabled channels

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#### **Switching Characteristics**

 $V_{CC} = 2 \text{ V}$ ,  $C_L = 50 \text{ pF}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 9 through Figure 14)

	PARAMETER	FROM	то	T	չ = 25°C		–40°C to 85°C		-40°C to 125°C		UNIT
'	FARAIVIETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay time	COM or Yn	Yn or COM	9.5	19.5	33	8	34	7	35	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay time	Channel Select	COM or Yn	14.6	24.5	38	14.4	40	12.8	42	ns
t <sub>PZH</sub>	Enable delay time	INH	COM or Yn	15	23.6	47.5	13.8	52.5	12.5	57.5	ns
t <sub>PHZ</sub>	Disable delay time	INH	COM or Yn	34.5	48.4	100	34.3	105	34	115	ns

#### **Switching Characteristics**

 $V_{CC} = 3 \text{ V}$ ,  $C_L = 50 \text{ pF}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 9 through Figure 14)

	PARAMETER	FROM	то	T,	∖ = 25°C		–40°C to 85°C		–40°C to 125°C		UNIT
	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time	COM or Yn	Yn or COM	3.6	12	17.5	4.5	19	3.2	20.5	ns
t <sub>PLH</sub>	Propagation delay time	Channel Select	COM or Yn	7.4	14.6	21	8.3	22.5	7.2	24	ns
t <sub>PZH</sub>	Enable delay time	INH	COM or Yn	7.9	13.8	45	6.2	50	5.5	55	ns
t <sub>PHZ</sub>	Disable delay time	INH	COM or Yn	31.2	44.5	90	31.5	100	31	110	ns

#### **Switching Characteristics**

 $V_{CC} = 3.3 \text{ V}$ ,  $C_L = 50 \text{ pF}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 9 through Figure 14)

	DADAMETED	FROM	то	T <sub>A</sub> = 25°C			–40°C to 85°C		-40°C to 125°C		UNIT
•	PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
t <sub>PLH</sub>	Propagation delay time	COM or Yn	Yn or COM	3.9	11	15.5	4	17	3.2	18.5	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay time	Channel Select	COM or Yn	6.4	13.5	19	6.5	20.5	5.5	22.5	ns
t <sub>PZH</sub>	Enable delay time	INH	COM or Yn	7	12.7	42.5	6.4	47.5	5.4	52.5	ns
t <sub>PHZ</sub>	Disable delay time	INH	COM or Yn	30	43.9	85	29.6	95	29.5	105	ns



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#### **Switching Characteristics**

 $V_{CC} = 4.5 \text{ V}$ ,  $C_L = 50 \text{ pF}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 9 through Figure 14)

	PARAMETER	FROM	то	T	₄ = 25°C		–40°C to 85°C		–40°C to 125°C		UNIT
	PARAIVIETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time	COM or Yn	Yn or COM	2.3	8.6	13	2.1	13.8	2	15.2	ns
t <sub>PLH</sub>	Propagation delay time	Channel Select	COM or Yn	5.3	11	16.6	5.5	18	4.6	19	ns
t <sub>PZH</sub>	Enable delay time	INH	COM or Yn	4	9.9	40	4.3	45	3.4	50	ns
t <sub>PHZ</sub>	Disable delay time	INH	COM or Yn	24.5	41.4	80	24.2	90	24	100	ns

#### **Switching Characteristics**

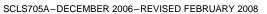
 $V_{CC} = 6 \text{ V}$ ,  $C_L = 50 \text{ pF}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 9 through Figure 14)

	PARAMETER	FROM	то	T	\ = 25°C		–40°C to 85°C		–40°C to 125°C		UNIT
'	FARAIVIETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time	COM or Yn	Yn or COM	2	8	11.8	2.3	13	1.8	13.5	ns
t <sub>PLH</sub>	Propagation delay time	Channel Select	COM or Yn	3.4	9.5	14.6	3.7	16	2.8	17.5	ns
t <sub>PZH</sub>	Enable delay time	INH	COM or Yn	2.8	8.4	39	3	40	2	40	ns
t <sub>PHZ</sub>	Disable delay time	INH	COM or Yn	12.4	38	78	11.5	80	11	80	ns

### **Operating Characteristics**

 $T_A = 25^{\circ}C$  (see Figure 15)

	PARAMETER	V <sub>CC</sub>	TEST CONDITIONS	TYP	UNIT
C D	Dower discinction conscitones	3.3 V	Noload	48	nE
C <sub>pd</sub>	Power dissipation capacitance	5 V	No load	60	ρг





#### **APPLICATION INFORMATION**

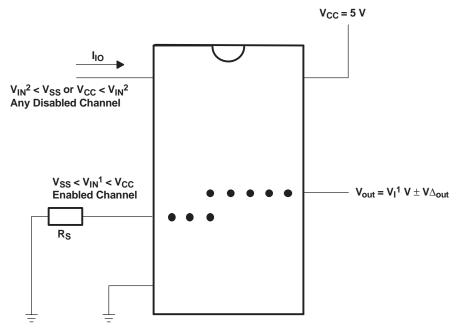


Figure 1. Injection-Current Coupling Specification

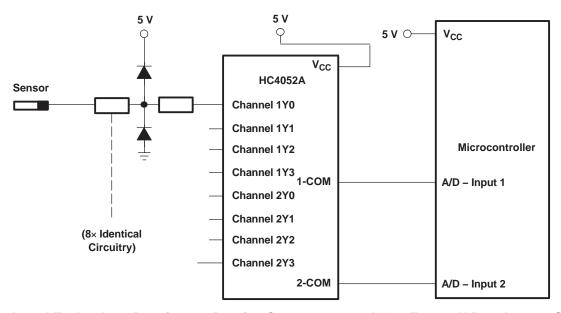


Figure 2. Actual Technology Requires 32 Passive Components and One Extra 6-V Regulator to Suppress Injection Current Into a Standard HC4052 Multiplexer



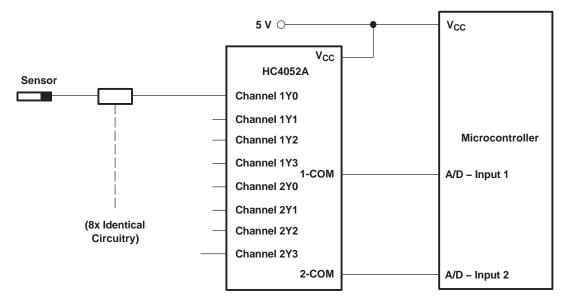


Figure 3. Solution by Applying the HC4852 Multiplexer

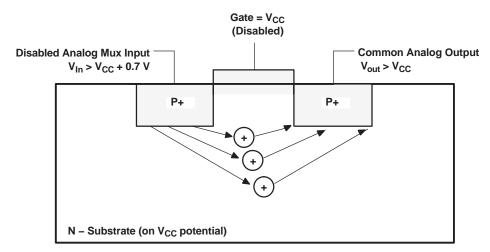


Figure 4. Diagram of Bipolar Coupling Mechanism (Appears if  $V_{IN}$  Exceeds  $V_{CC}$ , Driving Injection Current Into the Substrate)



## PARAMETER MEASUREMENT INFORMATION

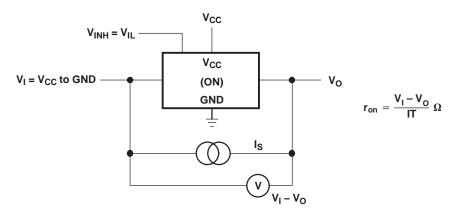


Figure 5. On-State Resistance Test Circuit

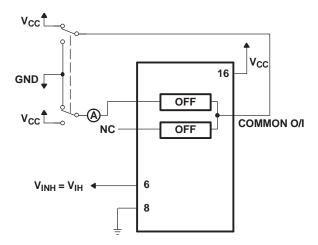


Figure 6. Maximum Off-Channel Leakage Current, Any One Channel, Test Setup

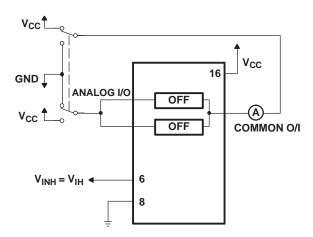


Figure 7. Maximum Off-Channel Leakage Current, Common Channel, Test Setup



#### PARAMETER MEASUREMENT INFORMATION (continued)

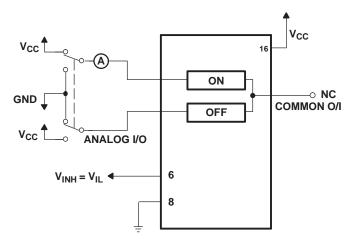


Figure 8. Maximum On-Channel Leakage Current, Channel to Channel, Test Setup

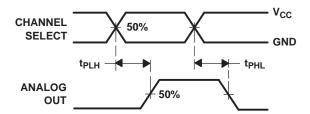


Figure 9. Propagation Delays, Channel Select to Analog Out

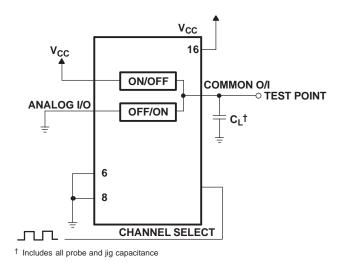


Figure 10. Propagation Delay, Channel Select to Analog Out, Test Setup



#### PARAMETER MEASUREMENT INFORMATION (continued)

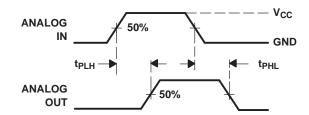
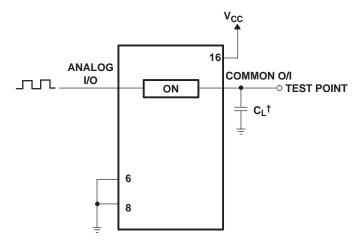


Figure 11. Propagation Delays, Analog In to Analog Out



† Includes all probe and jig capacitance

Figure 12. Propagation Delay, Analog In to Analog Out, Test Setup

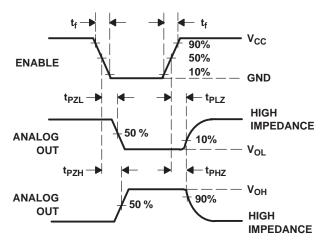


Figure 13. Propagation Delays, Enable to Analog Out



#### PARAMETER MEASUREMENT INFORMATION (continued)

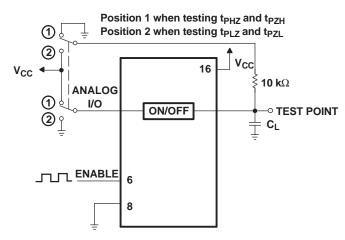


Figure 14. Propagation Delay, Enable to Analog Out, Test Setup

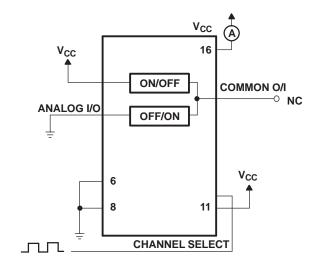


Figure 15. Power-Dissipation Capacitance, Test Setup





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#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins F	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74HC4852QDRQ1	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74HC4852QPWRQ1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN74HC4852-Q1:

Catalog: SN74HC4852

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

# D (R-PDS0-G16)

### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# D (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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